

Modified Form PTO/SB/08A

Substitute for form 1449A/PTO

**INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT**

(use as many sheets as necessary)

Sheet	1	of	3
Complete If Known			
Application Number		09/710,539	
Filing Date		November 9, 2000	
First Named Inventor		Eldridge et al.	
Group Art Unit		2839 2833	
Examiner Name		S. Nguyen & Tsukerman	
Attorney Docket No.		276440-3	

LT

U.S. PATENT DOCUMENTS						
Examiner Initials <sup>1</sup>	Cite No. <sup>1</sup>	U.S. Patent Document		Name of Patentee or Applicant	Publication Date	Relevant Portions
		Number	Kind Code <sup>2</sup>			
LT	1	H842		Ochs	11/6/1990	
LT	2	3519890		Ashby	7/7/1970	
LT	3	3842189		Southgate	10/15/1974	
LT	4	4615573		White et al.	10/7/1986	
LT	5	4893172		Matsumoto et al.	1/9/1990	
LT	6	5286208		Matsuoka	2/15/1994	
LT	7	5513430		Yanof et al.	5/7/1996	
LT	8	5534784		Lum et al.	7/9/1996	
LT	9	5555422		Nakano	9/10/1996	
LT	10	5576630		Fujita	11/19/1996	
LT	11	5599194		Ozawa et al.	2/4/1997	
LT	12	5666190		Quate et al.	9/9/1997	
LT	13	5701085		Malladi et al.	12/23/1997	
LT	14	5821763		Beaman et al.	10/13/1998	
LT	15	5829128		Eldridge et al.	11/3/1998	
LT	16	5914614		Beaman et al.	6/22/1999	
LT	17	5974662		Eldridge et al.	11/2/1999	
LT	18	6014032		Maddix et al.	1/11/2000	
LT	19	6016061		Mizuta	1/18/2000	
LT	20	6031282		Jones et al.	2/29/2000	

Examiner Signature	/Larisa Tsukerman/	Date Considered	10/27/2006
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication

<sup>1</sup>Unique citation designation number. <sup>2</sup>See attached Kinds of U.S. Patent Documents. <sup>3</sup>Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language Translation is attached.

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				Group Art Unit	2839 2833
				Examiner Name	S. Nguyen
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**U.S. PATENT DOCUMENTS**

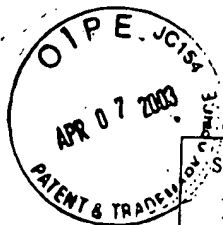
Examiner Initials	Cite No. <sup>1</sup>	U.S. Patent Document		Name of Patentee or Applicant	Publication Date	Relevant Portions
		Number	Kind Code <sup>2</sup>			
LT	21	6059982		Palagonia et al.	5/9/2000	
LT	22	6064213		Khandros et al.	5/16/2000	
LT	23	6072190		Watanabe et al.	6/6/2000	
LT	24	6183267	B1	Marcus et al.	2/6/2001	
LT	25	6184053	B1	Eldridge et al.	2/6/2001	
LT	26	6184576	B1	Jones et al.	2/6/2001	
LT	27	6214631	B1	Burrows et al.	4/10/2001	
LT	28	6255126	B1	Mathieu et al.	7/3/2001	
LT	29	6255727	B1	Khoury	7/3/2001	
LT	30	6289583	B1	Belmont et al.	9/18/2001	
LT	31	6307392	B1	Soejima et al.	10/23/2001	
LT	32	6344752	B1	Hagihara et al.	2/5/2002	
LT	33	6359455	B1	Takekoshi	3/19/2002	
LT	34	6452407	B2	Khoury et al.	9/17/2002	

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Sheet	3	of	3	Attorney Docket No.	276440-3

FOREIGN PATENT DOCUMENTS								
Examiner Initials <sup>1</sup>	Cite No. <sup>1</sup>	Foreign Patent Document			Name of Patentee or Applicant	Publication Date	Relevant Portions	T <sup>6</sup>
		Office <sup>2</sup>	Number <sup>3</sup>	Kind Code <sup>3</sup>				
LT	35	EP	632281		Pedder	1/4/1995		
LT	36	JP	58-191453		Kazuo	11/8/1983		x
LT	37	JP	05-18741		Kawase et al.	1/26/1993		x
LT	38	JP	05-198716		Osawa	8/6/1993		x
LT	39	JP	06-267408		Todokoro et al.	9/22/1994		x
LT	40	JP	07-21968		Watanabe et al.	1/24/1995		x
LT	41	JP	08-306708		Harada	11/22/1996		x
LT	42	WO	91/12706		Leedy	8/22/1991		
LT	43	WO	96/16440		Khandros et al.	5/30/1996		
LT	44	WO	98/21597		Charmant et al.	5/22/1998		
LT	45	WO	00/33096		Eldridge et al.	6/8/2000		
LT	46	WO	01/9952		Eldridge et al.	2/8/2001		

OTHER PRIOR ART - NONPATENT LITERATURE DOCUMENTS			
Examiner Initials <sup>1</sup>	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T <sup>6</sup>
LT	47	"A New Wafer Probe Interface Technology Using Compliant Microsprings, A Joint Study by Teradyne, Inc. and FormFactor, Inc.," Teradyne Formfactor White Paper (Teradyne, Inc. and FormFactor, Inc., January 30, 1998), pp. 1-18	
LT	48	NOVITSKY et al., "FormFactor Introduces An Integrated Process For Wafer-Level Packaging, Burn-in Testing, And Module Level Assembly" (FormFactor, Inc., March 1999), 6 pages	
LT	49	KHANDROS et al., "New Methods For Reducing Costs In Semiconductor Back-End," (FormFactor, Inc., January 30, 1998), 9 pages	

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